Form PTO 1449		U.S. DEPARTMENT C		ATTY DOCKET NO.		SERIAL NO.		
(Modified)		PATERT AND TRADEMARK OFFICE		219282US3		NEW APPLICATION		
				APPLICANT APPLICANT				
LIST OF REFERENCES CITED BY APPLICANT				Shigeo MURAMAT		SU, et al.		
_				FILING DATE		GROUP >		
				HEREWITH		000		
U.S. PATENT DOCUMENTS								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
KOT	AA	5,774,305	06/30/98	Zine-Eddine, BOUTAGHOU				
	AB							
	AC			•				
	AD							
	AE							
	AF							
	AG							
	AH			·				
	Al							
	AJ							
	AK							
	AL							
	AM							
	AN			· · · · · · · · · · · · · · · · · · ·	<u> </u>			
FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY	COUNTRY		TRANSLATION	
KOT	AO	10-198935	07/31/98	JAPAN (with English Abstract)		YES	NO X	
The state of the s	AP	2000-30233	01/28/00	JAPAN (with English Abstract)			×	
	AQ	11-250434	09/17/99	JAPAN (with English Abstract)			X	
	AR	11-238218	08/31/99	JAPAN (with English Abstract)			x	
	AS	11-86253	03/30/99	JAPAN (with English Abstract)			×	
	AT	10-222941	08/21/98	JAPAN (with English Abstract)			×	
	AU	8-255449	10/01/96	JAPAN (with English Abstract)			×	
NOT	AV	7-262541	10/13/95	JAPAN (with English Abstract)			×	
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
	AW			· · · · · · · · · · · · · · · · · · ·				
	AX							
<u>`</u> _	AY							
					Additional References sheet(s) attached			
Examiner ————————————————————————————————————		111.111	In		Date Considered 5/28/04			
*Examiner: Initial if reference is considered, whether of not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								
		PRIMARY EXAM	IVEIV					